## MSKSEMI















**ESD** 

TVS

TSS

MOV

GDT

**PLED** 

# Broduct data sheet

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#### **Features**

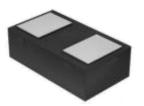
■ Ultra Low Capacitance: 0.30pF(typ.)

■ Reverse Working Voltage: 5V

■ IEC 61000-4-2 (ESD Air): ±20kV

IEC 61000-4-2 (ESD Contact): ±20kV IEC 61000-4-5 (Lightning 8/20µs): 5A

#### 2. Pin Description



## **Applications**

- Smart Phone and Tablet PC
- TV and Set Top Box
- Wearable Devices
- PDA

#### 4. Schematic Diagram



#### **Order Information**

Туре	Package	Size (mm)	Delivery Form	Delivery Quantity
RCLAMP0521P-MS	DFN1006	1.00x0.60x0.37	7" T&R	10,000

## Limiting Values( $T_A = 25$ °C, unless otherwise specified)

Symbol	Parameter	Conditions		Max	Unit
$V_{ESD}$	Electrostatic Discharge Voltage	IEC 61000-4-2; Contact Discharge	-	±20	kV
		IEC 61000-4-2; Air Discharge	-	±20	kV
P <sub>PP</sub>	Peak Pulse Power	t <sub>P</sub> = 8/20 μs	-	110	W
I <sub>PPM</sub>	Rated Peak Pulse Current	t <sub>P</sub> = 8/20 μs	-	5.0	Α
T <sub>A</sub>	Operating Temperature Range	-	-55	125	°C
$T_{stg}$	Storage Temperature Range	-	-55	150	°C

## Electrical Characteristics(T<sub>A</sub> = 25 °C unless otherwise specified)

Symbol	Parameter	Conditions	Min	Тур.	Max	Unit
$V_{RWM}$	Reverse Working Voltage	T <sub>A</sub> = 25 °C	-	-	5.0	V
$V_{BR}$	Breakdown Voltage	I <sub>R</sub> = 1mA; T <sub>A</sub> = 25 °C	6.0	8.5	9.5	V
$I_{R}$	Reverse Leakage Current	V <sub>RWM</sub> = 5V; T <sub>A</sub> = 25 °C	-	-	0.1	μA
Vc	Clamping Voltage	I <sub>PP</sub> =1A, t <sub>P</sub> =8/20μs	-	-	10	V
		I <sub>PP</sub> =5.0A, t <sub>P</sub> =8/20μs	-	-	22	V
Сл	Junction Capacitance	V <sub>R</sub> = 0V, f = 1 MHz	-	0.30	0.40	pF

## **Typical Characteristics**

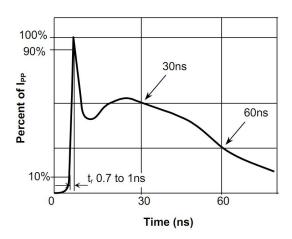


Fig.1 Pulse Waveform-ESD (IEC61000-4-2)

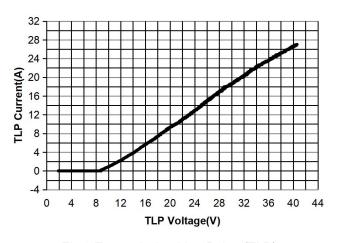


Fig.2 Transmission Line Pulse (TLP)

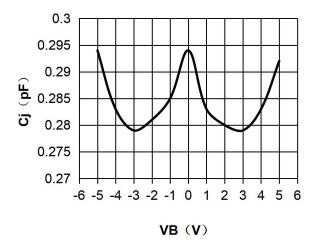


Fig.3 Capacitance vs. Reveres Voltage

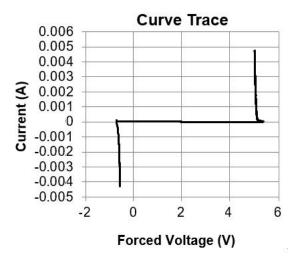
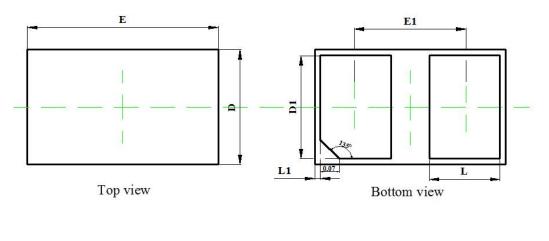
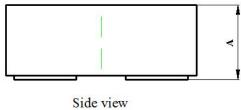


Fig.4 IV Curve



## DFN1006-2





Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min	Max	Min	Max	
Α	0.350	0.450	0.014	0.018	
D	0.550	0.650	0.022	0.026	
E	0.950	1.050	0.037	0.041	
D1	0.420	0.520	0.017	0.020	
E1	0.550	0.650	0.022	0.026	
L	0.270	0.370	0.011	0.015	
L1	0.000	0.100	0.000	0.004	



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